

| | | | | |
|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/715,134 | | Applicant(s)/Patent Under Reexamination SANDOVAL, YVONNE | |
| | Examiner David J. Walczak | | Art Unit 3751 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-6,554,902 | 04-2003 | Yan, Ruey Fwu | 118/264 |
| * | B | US-6,065,890 | 05-2000 | Weitz, Gene C. | 401/146 |
| * | C | US-5,050,530 | 09-1991 | Studebaker et al. | 118/264 |
| * | D | US-4,542,549 | 09-1985 | Keller, Hannah R. | 15/1.7 |
| * | E | US-2,610,346 | 09-1952 | PUGH LAURA S | 15/210.1 |
| * | F | US-1,542,925 | 06-1925 | WAMBOLD HAROLD M | 401/155 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.